

# THE USE OF COTS COMPONENTS FOR SPACE APPLICATIONS

ACCFDF

**COTS2019** 

SEVILLE - SPAIN 6-8 NOVEMB

## ACCEDE WORKSHOP-7<sup>TH</sup> NOVEMBER 2019 SEVILLA





# AGENDA

### INTRODUCTION

- Vishay company overview

### VISHAY QUALIFICATION LEVEL

- Vishay qualification Hierarchy
- Space client's preference
- Space qualification Vs Automotive qualification
- VISHAY PASSIVE COMPONENTS QUALITY COMPARISON
  - Resistors : Thin Film
  - Capacitors: Tantalum Molded





PASSIVES

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49%

#### VISHAY REVENUES 2018: \$3BILLION

51%

SEMICONDUCTORS





#### **BROAD PRODUCT PORTFOLIO**

**VISHAY TODAY** 



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#### BROADEST LINE OF DISCRETE SEMICONDUCTORS AND PASSIVE COMPONENTS

	SEMICONDUCTORS				PASSIVE COMPONENTS						
	DIODES	MOSFETs		OPTO		CAPAC	ITORS	F	RESISTOR	S	MAGNETICS
	Diodes, Rectifiers	MOSFETs	Infrared Compo- nents	Opto- couplers	LEDs	Aluminum, Ceramic	Power, Film, Tantalum	Film, Power	SMD Resistors	Variable, Sensors	Magnetic Components
VISHAY				•	0	0				0	•
AVX											
Bourns									0		
Broadcom											
Diodes Inc.											
Infineon	0										
KEMET						0					
KOA											0
Murata										0	
Nichicon							0			0	
Nexperia											
ON Semi					0						
Panasonic										0	0
Rohm				0	0		0				
Sharp					0						
ST Micro											
TDK/EPCOS											
Toshiba					0						
Yageo								0			0
Source:	Company es	stimates		= Major	Position	O = Minor	Position				



- VISHAY QUALIFICATION HIERARCHY
- SPACE CLIENT'S PREFERENCE
- SPACE VS AUTOMOTIVE QUALIFICATION





# **QUALIFICATIONS AND STANDARDS**

- MIL (Military Specifications)
- ER (Established Reliability)
- CECC (CENELEC Electronic Components Committee)
- AS9100 (Aerospace Quality Management System)
- NASA (National Aeronautics and Space Administration Standards)
- ESA (European Space Agency)
- AEC-Q100 / 101 / 200 (Automotive Qualification Standard)
- ISO 9001 (Quality Management System)
- IATF 16949:2016 (International Automotive Task Force)
- ISO / TS 16949 (Automotive Quality System)
- VDA 6.3 (German Automotive Industry Quality Standard)
- UL (Underwriters Laboratories)
- ISO 14001 (Environmental Management System)
- OHSAS 18001 (Occupational Health and Safety Management System)
- IRIS (International Railway Industry Standards)
- ISO 13485 (Medical Devices Quality Management System)
- ISO 50001 (Energy Management System)



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## **SPACE CLIENT'S PREFERENCES (1)**

	Auto Quality acc. AEC-Q200	COTS*	Qualified e.g. IECQ-CECC	Space qualified e.g. ESCC
Initial Product Evaluation	NO	NO	NO	<b>YES</b> with DPA
SnPb Plated Version Available	NO	NO NO		YES
Long Term Quality Record	NO	NO	YES	NO
Screening (Prevention of early failures)	NO	NO	YES	YES
Unique Production Lot per Package (SLDC)	NO	NO	Est. Rel.: <b>YES</b>	YES
Certificate of Conformity	NO	NO	Marking on label only	<b>YES</b> with data
Traceability	YES	YES	YES	YES
Low Quantities Available (< 1000 pcs.)	NO	NO	NO	YES
Lot Validation Tests Available	NO	NO	NO	YES



## **SPACE CLIENT'S PREFERENCES (2)**

	Automotive Quality acc. COTS* AEC-Q200		Qualified e.g. IECQ-CECC	Space qualified e.g. ESCC	
Qualification Test Schedule	YES	NO	YES	YES	
Requalification	Upon Product Change	pon Product NO Change		Periodical	
Quality Conformance Test Schedule	NO	NO	YES	YES	
100% Resistance Test	YES	YES	YES	YES	
100% Additional Tests	NO	NO NO		YES	
100% Human Visual Inspection	NO	NO	NO	YES	
Factory Audits by Qualifcation Body	NO	NO	YES	YES	
Client's Delta-Qualification Effort					



### **MAIN VARIATIONS BETWEEN ESCC & AEC-Q**

AEC-Q	ESCC			
Stress tests qualification list only related to the product	Stress tests qualification list for product + process qualification + system qualification			
Statistical approach to guaranty conformity on huge volume during all life duration : maintenance possible	Reliability (failure rate) approach : no maintenance possible			
100% functional performances evaluated based on statistics	100% <mark>screening</mark> (burn-in, overload) + 100% visual inspection			
Temperature range -40°C / +125°C (Most underhood) No radiation requirement	Temperature range -55°C / +155°C Robustness to radiation (test specification)			
Mutual qualification (Manufacturer / Customer)	Third part qualification (ESA)			
Typical life time up to 15 years (spare parts)	Typical lifetime 20 years (application)			
IATF16949	ESCC Cesa			



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FAILURE

RATE

ESCC system

100% RFFNING



# VISHAY PASSIVE COMPONENT QUALITY COMPARISON

# - RESISTORS : THIN FILM - CAPACITORS: TANTALUM MOLDED



VISHAY.	THIN FILM RESISTORS MATRIX								
Serie	Resistor Qualif Type		Temp rangeLoad life°Cstability		Tol %	TC <u>+</u> ppm/°C			
P PHT		EN9100	-55°C +155°C -55°C +215°C	± 0.1 % typ (8000h @P70)	± 0.01 to ± 5	± 5 to ± 100			
PHR	Chip	·e	-55°C+155°C	± 0.02 % typ (2000h @P70 )	± 0.01 to ± 0.1	± 5 to ± 25			
PFRR		•	-55°C+155°C	± 0.05 % typ (8000h @P70)	± 0.05 to ± 0.1	± 10 to ± 25			
PTN		MIL	-55°C+155°C	± 0.03 % typ (2000h @P70 )	± 0.05 to ± 5	± 10 to ± 100			
MC-AT			-55°C+125°C	± 0.15 % typ (1000h @P70 )	± 0.5 to ± 1	± 25 to ± 50			
TNPU			-55°C+125°C	± 0.05 % typ (1000h @P70 )	± 0.02 to ± 0.1	± 5 to ± 10			
PRA CNW	Network	EN9100	-55°C+155°C	± 0.1 % abs ± 0.02 % ratio (1000h @P70 )	$\pm$ 0.1 to 0.5 abs $\pm$ 0.01 to 0.1 ratio	$\pm$ 10 abs $\pm$ 1 to 2 ratio			
PRAHR CNWHR		·e	-55°C+155°C	± 0.1 % abs ± 0.02 % ratio (1000h @P70 )	$\pm$ 0.1 to 1 abs $\pm$ 0.05 to 0.1 ratio	± 10 abs ± 3 ratio			
ACAS		AUTOMOTIVE GRADE	-55°C+155°C	± 0.1 % abs ± 0.05 % ratio (1000h @P70 )	± 0.1 abs ± 0.05 ratio	± 10 abs ± 5 ratio			





# Solid Tantalum: SMD, Space or "T level"

MIL-PRF-55365: CWR06 – Standard Values CWR16 – Extended Range Values CWR26 – Low ESR CWR11 – molded case Failure Rate: "C" (0.01%/1000 Hours) Surge Current Test Option "C": -55° C & +85° C



Group A Inspection	Sample	Description
Reflow Conditioning	100%	230°C Minimum, 5 Seconds Minimum
Thermal Shock (Unmounted)	100%	5 Cycles, $-65^{\circ}$ C to $+125^{\circ}$ C
Weibull FRL Grading	100%	"C" Level Minimum (0.01%/1k Hours)
Surge Current Test	100%	-55°C & +85°C, Before Weibull Grading
Radiographic Inspection	100%	2 plane X-ray
DPA (Destructive Physical Analysis	5	MIL-STD-1580 Modified by MIL-PRF-55365
Visual	100%	10X Magnification
Temperature Stability	13	-55°C to +125°C
Solderability	13	MIL-STD-202, Method 208
Group C Inspection	Sample	Description
Thermal Shock (Mounted)	12	10 Cycles, $-65^{\circ}$ C to $+125^{\circ}$ C
Resistance to Solder Heat	19	235°C for 30 seconds, 1 Cycle
Mositure Resistance	10	+25°C to +65°C for 24 hours, 20 cycles
Life	24	2000 Hours at +125°C



#### MIL-PRF-55365, Level "T" processing meets NASA/TP-2003-212242, Level 1 requirements.

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# Space Level

#### Series: T83, T95, T97, TM8

MIL-PRF-55365 (CWRXX "T" Level), DSCC specified and COTS products are available for Space applications. Meets Class K, Element Evaluation per MIL-PRF-38534 (Hybrids) Supports NASA/TP-2003-212242; EEE-INST-002, Level 1

#### SPACE LEVEL SMD PROCESSING COMPARISON

Test Description	Test Method	Level T	Hybrid (MIL-PRF-38534)	Vishay COTS
100% Reflow Conditioning	MIL-PRF-55365	Х	Х	Х
100% Thermal Shock (Unmounted)	MIL-PRF-55365	Х	X	Х
100% Voltage Aging (Weibull B or better)	MIL-PRF-55365	Х	Х	Х
100% Surge Current (Option C: -55°C & +85°C)	MIL-PRF -55365	Х	X	Х
100% Electrical Screening	MIL-PRF-55365	Х	Х	Х
100% Visual/Mechanical	MIL-PRF-55365	Х	Х	Х
Solderability	MIL-PRF-55365	Х	X	Х
Temperature Stability	MIL-PRF-55365	Х	X	Х
DPA Analysis	MIL-STD-1580	Х	X	Х
100%X-ray	MIL-PRF-55365	Х	X	Х
Group C Testing (Each Lot)	MIL-PRF-55365	Х		Available
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